XN09D61

Silicon PNP epitaxial planar type (Tr) Silicon epitaxial planar type (SBD)

For DC-DC converter

■ Features

- Two elements incorporated into one package (Tr + SBD)
- Reduction of the mounting area and assembly cost by one half
- Low collector-emitter saturation voltage V_{CE(sat)}

■ Basic Part Number

• 2SA2046 + MA3ZD12

■ Absolute Maximum Ratings $T_a = 25$ °C

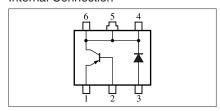
Parameter		Symbol	Rating	Unit	
Tr	Collector-base voltage (Emitter open)	V _{CBO}	-15	V	
	Collector-emitter voltage (Base open)	V _{CEO}	-15	V	
	Emitter-base voltage (Collector open)	V _{EBO}	-5	V	
	Collector current	I_{C}	-1.5	A	
	Peak collector current	I_{CP}	-3	A	
SBD	Reverse voltage	V_R	20	V	
	Repetitive peak reverse voltage	V _{RRM}	25	V	
	Forward current (Average)	I _{F(AV)}	700	mA	
	Non-repetitive peak forward surge current	I_{FSM}	2	A	
Overall	Total power dissipation *	P_{T}	600	mW	
	Junction temperature	T_{j}	125	°C	
	Storage temperature	T_{stg}	-55 to +125	°C	

Note) *: Measuring on ceramic substrate at 15 mm \times 15 mm \times 0.6 mm

1: Emitter 2: Base 3: Anode Unit: mm 0.16^{+0.10}_{-0.05} 0.30^{+0.10}_{-0.05} 0.16^{+0.10}_{-0.05} 0.16⁺⁰

Marking Symbol: RA

Internal Connection



■ Electrical Characteristics $T_a = 25$ °C ± 3 °C

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Parameter	Symbol	Conditions	Min	Тур	Max	Unit
Collector-base voltage (Emitter open)	V _{CBO}	$I_C = -10 \ \mu A, I_E = 0$	-15			V
Collector-emitter voltage (Base open)	V _{CEO}	$I_C = -1 \text{ mA}, I_B = 0$	-15			V
Emitter-base voltage (Collector open)	V_{EBO}	$I_E = -10 \ \mu A, I_C = 0$	-5			V
Collector-base cutoff current (Emitter open)	I_{CBO}	$V_{CB} = -10 \text{ V}, I_E = 0$			- 0.1	μΑ
Forward current transfer ratio *	h _{FE}	$V_{CE} = -2 \text{ V}, I_{C} = -100 \text{ mA}$	160		560	_
Collector-emitter saturation voltage *	V _{CE(sat)}	$I_C = -750 \text{ mA}, I_B = -15 \text{ mA}$		-90	-200	mV
		$I_C = -1.5 \text{ A}, I_B = -50 \text{ mA}$		-130		

Note) 1. Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7030 measuring methods for transistors.

^{2. *:} Pulse measurement

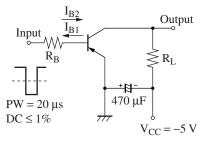
■ Electrical Characteristics (continued) $T_a = 25$ °C ± 3 °C

• Tr (continued)

Parameter	Symbol	Conditions	Min	Тур	Max	Unit
Collector output capacitance	C _{ob}	$V_{CB} = -10 \text{ V}, I_E = 0, f = 1 \text{ MHz}$		25	35	pF
(Common base, input open circuited)						
Transition frequency	f_T	$V_{CB} = -2 \text{ V}, I_E = 100 \text{ mA}, f = 200 \text{ MHz}$		270		MHz
Turn-on time	t _{on}	Refer to the switching time measurement circuit		25		ns
Storage time	t _{stg}			70		ns
Turn-off time	t _{off}			15		ns

Note) Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7030 measuring methods for transistors.

Switching time measurement circuit



$$-20I_{B1} = 20I_{B2} = I_C = -750 \text{ mA}$$

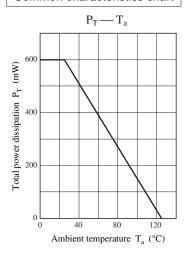
• SBD

Parameter	Symbol	Conditions	Min	Тур	Max	Unit
Forward voltage	V _F	$I_F = 700 \text{ mA}$			0.45	V
Reverse current	I_R	$V_R = 20 \text{ V}$			200	μΑ
Terminal capacitance	Ct	$V_R = 0$, $f = 1$ MHz		100		pF
Reverse recovery time	t _{rr}	$I_F = I_R = 100 \text{ mA}, I_{rr} = 10 \text{ mA}$		7		ns
		$R_r = 100 \Omega$				

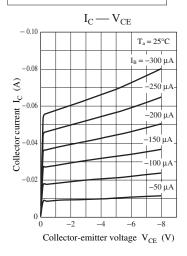
Note) 1. Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7031 Measuring methods for diodes.

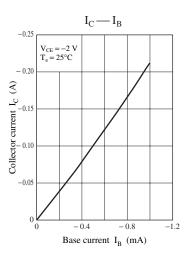
2. Schottky barrier diode is frail with static electricity, and it should be kept in safety from shock of static electricity and static electricity level.

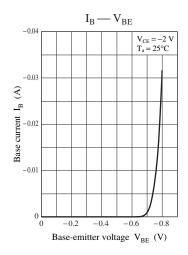
Common characteristics chart

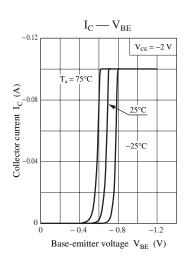


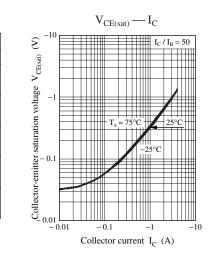
Characteristics charts of Tr

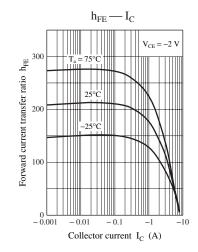


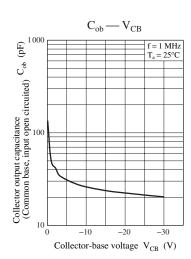






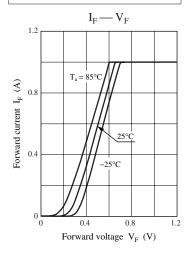


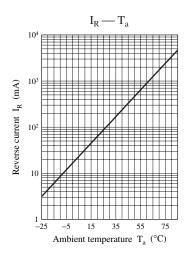


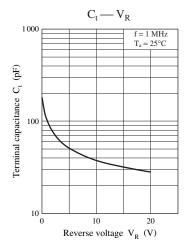


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Characteristics charts of SBD







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